


<b>Search Notes</b>  	<b>Application/Control No.</b>  09550649	<b>Applicant(s)/Patent Under Reexamination</b>  GUERTIN ET AL.
	<b>Examiner</b>  Kim, David S	<b>Art Unit</b>  2613

### SEARCHED

Class	Subclass	Date	Examiner
398	27	11/03/2005	DSK
714	716	11/03/2005	DSK
398	26, 27	5/24/2006	DSK

### SEARCH NOTES

Search Notes	Date	Examiner
EAST search - see search history printout	11/03/2005	DSK, 11/04/06
text search in 714/704-717	11/03/2005	DSK
www.google.com - various combinations of the following terms: wdm dwdm loopback "loop back" cascade chain test sectionalize ber test wavelength channel serial daisy optical testing t-berd 310 bit error tester sections bert		DSK, 11/2006
scholar.google.com - various combinations of the following terms: sectionalize wdm dwdm ber bert test equipment monitor section chain cascade daisy		DSK, 11/2006
EAST search - see search history printout	5/24/2006	DSK
www.google.com - various combinations of the following terms: measure ber q-factor calculate	5/24/2006	DSK
scholar.google.com - various combinations of the following terms: q-factor "q factor" ber monitor tester bert	5/24/2006	DSK
EAST search - see search history printout	4/24/2007	DSK, 4/25/2007
scholar.google.com - various combinations of the following terms: ber "bit error" test daisy chain wdm ransford monitor	4/25/2007	DSK
ieeexplore.ieee.org - search string: ransford<in>au	4/25/2007	DSK
scholar.google.com - Q adjust decision threshold	10/25/2007	DSK
www.google.com - search string: cien juniper networks m40 internet backbone white paper	11/13/2008	DSK

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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